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LIST OF	ART CITE	P-0751		APPLN. SERIAL NO. New U.S. Patent Application				
	(PTO-	1449)		APPLICANT(S) Sang-Ik LEE; HWANG	Eun-Jeong	KIM and Yeo	n-Yi	
				FILING DATE April 20, 2005		GROUP To be assigned		
U.S. PATEN	T DOCUMENTS							
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME		CLASS	SUBCLASS		ING ATE
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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY		CLASS	SUBCLASS	Trans Yes	No No
140	JP2150682	6/8/1990	Japan				AB	
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only	GB2079424	1/20/1982	Great Britain			· ·	<u> </u>	
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OTHER /	ART (Including A	Author, Title,	Date, Pertinen	Pages, Publis	her, Place o	of Publicatio	n, Etc.)
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EXAMINER	DATE CONSIDERED							
								

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

KE 1-25-2008